

Spring-loaded test probe

GKS-003 302 127 A 2000

Item GKS-003-0015



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Partner for Future Technology

- Robust, compact design for harsh ICT/FCT applications with limited space
- For optimum contact at the test points (e.g. pads, vias, and pins), various tip styles in different diameters and finishes, as well as various spring forces are available.

General data

Product group	ICT / FCT (in-circuit test and function test)
Sub-product group	Short/robust GKS
Series	GKS-003
Grid	3.18 mm [125 mil]
Contacting from	Pin, post, bead probe, flat contact
Magnetic	Yes
Installation type	Plug-in
Quick-exchange system	Yes
Adjustable installation height	No
Non-rotating	No
Compatible receptacle(s)	KS-003
Min. temperature	- 40 °C [- 104 °F]
Max. temperature	+ 80 °C [+ 176 °F]
RoHS-compliant	RoHS-3;6c

Electrical data

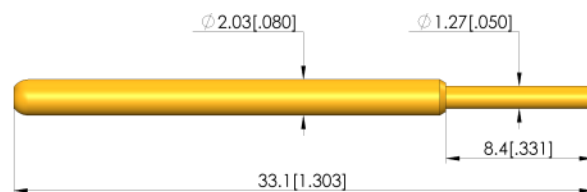
Current load capacity / rated current	8 A
Typical resistance (Ri)	<20 mOhm

Mechanical data

Total length	33.1 mm [1.30 in]
Barrel diameter	2.03 mm [.079 in]
Maximum stroke	6.35 mm [.25 in]
Spring pre-load	0.85 N [3.05 ozf]
Collar height	.00
Spring force at working stroke	2 N [7.19 ozf]
Recommended working stroke	4.4 mm [.173 in]

Tip style data

Tip style	02 flat
Tip diameter	1.27 mm [.05 in]
Tip style surface	A gold
Tip style material	3 CuBe



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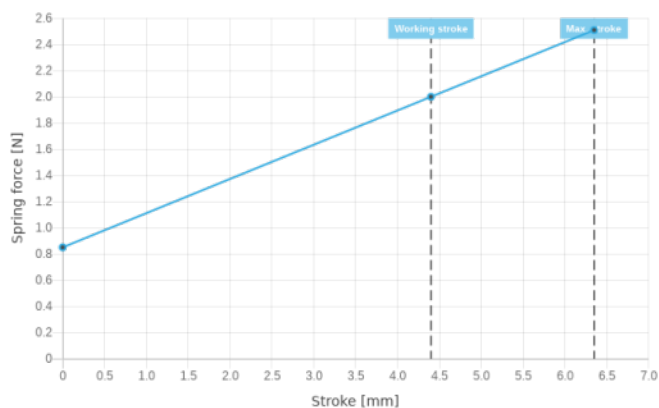
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